

Sicherheit in Technik und Chemie

The BAM Data Store: Piloting an openBIS-Based Research Data Infrastructure for Materials Science and Engineering

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BAM at a Glance





Materialprüfungsamt Lichterfelde in 1904



In Berlin & Brandenburg



1660 Employees



Enabling FAIR Data at BAM





Current RDM Practices at BAM





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The BAM Data Store - an institutional RDM Framework for Materials Science and Engineering

BAM Data Store Framework and underlying openBIS Framework



openBIS: open Biology Information System Underlying framework & open source software developed by ETH Zurich since 2007

- Electronic lab notebook (ELN)
- ✓ Inventory management
- ✓ Data management



BAM Data Store:

Framework for central RDM system at BAM, developing since 2021

- Infrastructure
- Work packages for tool adoption and continuous operation

BAM Data Store - General Structure





Piloting the BAM Data Store: Five Groups in 2021

Data Store Stewards are trained Domain researchers



	Activity	Methodologies
1 Thermal Analysis Microplastics	Determination of microplastic content in environmental samples.	Thermal analysis
2 Structural Health Monitoring	Assessment of aging infrastructure structures with digital technologies.	Monitoring data, Sensors, photos, videos, simulation models, etc.
3 Nanoplatform	Synthesis and characterization of nanomaterials, reference nanomaterials.	Diverse methods >90 Instruments
4 Computer Tomography@BAM	Material characterization with 3D imaging (CT).	Computer Tomography (CT)
5 Additive Manufacturing	Defect detection during the construction process.	Thermography, Tomography, etc.

BAM Data Store Implementation –nanoPlattform Project



Research data centrally stored from > 30 researchers and technical staff from diverse BAM locations Data registered in inventory and ELN for >150 chemicals, >90 Instruments, >800 experimental steps

Meta(data) collected from >400 synthesized Nanomaterials



BAM Data Store Implementation – nanoPlattform Project





Source: Datenmanagement im Nanomaterial-Labor - 2023 - Wiley Analytical Science

12.09.2023 The BAM Data Store - an institutional RDM Framework for Materials Science and Engineering

BAM Data Store Implementation – Lessons Learned



The BAM Data Store meets most of the RDM needs of heterogenous MSE groups:

- > openBIS can be used with all levels of data literacy.
- Enables standardised data documentation and traceability.
- Initial customisation is time-consuming due to lack of metadata standards in MSE domains.
- > Automating workflows for data import and integrated data analysis saves time.

Continous operation of an institutional RDM system requires resources and governance structures:

- ✓ Close collaboration between eScience and IT departments as well as the domain researchers.
- ✓ Additional IT resources and personel for training and support.
- ✓ Upper management support.
- ✓ Willingness to embrace cultural change to adopt RDM tools.

BAM Data Store – Rollout Phase to Achieve Continuus Operation (2023)





The BAM Data Store Framework for Tool Adoption \ge BAM and Continuous Operation



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